Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/802,056	CHOI ET AL.
Examiner	Art Unit
Dalena Tran	3661

	SEAR	CHED	
Class	Subclass	Date	Examiner
701	220 -		
10 1	22		
	213	_	•
	217		
73	1.38	12/10/06	77
342	357.08		
	357.14		
	457		
	<u>'</u>	,	
	·		
			-

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
			-		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
FAST	11/30/05	DT
•		
•		
		٠